

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE**INFORMATION DISCLOSURE
STATEMENT**Docket Number:
10191/3838

Application Number To Be Assigned	Filing Date Herewith	Examiner To be assigned	Art Unit To be assigned
Invention Title METHOD AND DEVICE FOR FUNCTION TESTING AN ANALOG-DIGITAL CONVERTER AND AN ANALOG-DIGITAL CONVERTER		Inventor(s) HAAG, Wolfgang et al.	

Address to:
 Mail Stop PCT
 Commissioner for Patents
 P.O. Box 1450
 Alexandria, VA 22313-1450

- I. In accordance with the duty of disclosure under 37 C.F.R. § 1.56 and in conformance with the procedures of 37 C.F.R. §§ 1.97 and 1.98 and M.P.E.P. § 609, attorney for Applicants hereby bring the following references to the attention of the Examiner. The references are listed on the attached modified PTO Form No. 1449. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that these references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.
- II. A copy of each patent, publication or other information listed on the modified PTO form 1449 is enclosed, except as otherwise indicated on the modified PTO form 1449.

Dated: 9/29/04

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INFORMATION DISCLOSURE STATEMENT BY APPLICANTS PTO FORM 1449	ATTY. DOCKET NO. 10191/3838	SERIAL NO. 107509639 To Be Assigned
	APPLICANT(s) HAAG, Wolfgang et al.	
	FILING DATE Filed Herewith	GROUP To Be Assigned

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	PATENT DATE	NAME	CLASS	SUBCLASS	FILING DATE

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
						YES	NO
	WO 02 15404	February 21, 2002	PCT			X **	
	WO 96 31690	October 10, 1996	PCT			X **	
	JP 02 041029	February 9, 1990	Japan			X **	
	WO 01 10031	February 8, 2001	PCT			X **	
	EP 0 474 024	March 11, 1992	EPO			X **	
	DE 195 13 081	October 10, 1996	Germany			X *, **	

* Mentioned in Specification.

** Copy of reference is not enclosed because reference is cited in Search Report (copy of reference provided by International Searching Authority).

OTHER DOCUMENTS

EXAMINER INITIAL	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
	** Patent Abstracts of Japan, Vol. 014, no. 194 (E-0919), 20 April 1990 (1990-04-20).
	* "PC gesteuerte Messtechnik ..." ["PC-controlled measuring technology ..."] by Klaus Dembowski, Markt - und Technik Verlag, 1993. (No Abstract)

* Mentioned in Specification.

** Copy of reference is not enclosed because reference is cited in Search Report (copy of reference provided by International Searching Authority).

EXAMINER	DATE CONSIDERED
EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	